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Design and Implement Area Optimization and Reduced Delay in Different type of Adders

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ABSTRACT: Due to continuous scaling of the transistor size and reduction of the operating voltage has led to a significant performance improvement of integrated circuits. Low power consumption and smaller area are some of the most important criteria for the fabrication of DSP systems and high performance systems. At the same time, the power consumption per chip also increases significantly due to the increasing density of the chip.

Therefore comparison has been carried out by assuming the circuits with minimum size transistors, to minimize the power consumption. Power consumption is a function of load capacitance, frequency of operation, and supply voltage. A reduction of any one of these parameter is beneficial. A reduction in power consumption provides several benefits. Less heat is generated, which reduces problems associated with high temperature, such as the need for heat sinks. This provides the consumer with a product that costs less.

From comparison we see that the power consumption of GDI based adder is 50% less from RBSD adder but 26% less speed as compared to conventional RBSD adder. Speed & power dissipation of CMOS adder is 10% & 39% less as compared to RBSD respectively.

Also CMOS adder has high noise margin as compared to other types of adders. Layouts of these adders are designed using Micro wind. From area comparison we see that area of GDI based adder is also 11% less than RBSD adder.

I. INTRODUCTION

Rapid growth in semiconductor technology has led to shrinking of feature sizes of transistors using deep submicron (DSM) process. Modern portable battery operated devices such as cell phones, laptops; PDAs are particularly affected by this as high power dissipation reduces battery service life. The adder is the most commonly used arithmetic block of the Central Processing Unit (CPU) and Digital Signal Processing (DSP), therefore its performance and power optimization is of utmost importance. With the technology scaling to deep sub-micron, the speed of the circuit increases rapidly. At the same time, the power consumption per chip also increases significantly due to the increasing density of the chip. Therefore, in realizing modern Very Large Scale Integration (VLSI) circuits, low-power and high-speed are the two predominant factors which need to be considered. Like any other circuits' design, the design of high-performance and low-power adders can be addressed at different levels, such as architecture, logic style, layout, and the process technology. As the result, there always exists a trade-off between the design parameters such as speed, power consumption, and area. Recently, the requirement of probability and the moderate improvement in battery performance indicate power dissipation is one of the most critical design parameters day by day the demand of probability and mobility is increasing.

Also the area of chip design is taken into consideration while talking about probability. Hence three most widely accepted parameters to measure the quality of a circuit or to compare various circuit styles are area, delay and power dissipation. There are three major sources of power consumption in digital CMOS circuits, which are summarized in the following equation

$$P_{Total} = P_{Switching} + P_{Short+Circuit} + P_{Leakage}$$

The first term represents the switching component of power. The short circuit power dissipation is due to the direct path from short circuit currents I_{sc} , which arises when both the NMOS and PMOS transistors are active, conducting current

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directly from power supply to ground. Finally, leakage current power dissipation arises from substrate injection and sub threshold effects, which is primarily determined by fabrication technology considerations. The objective of our dissertation is to design a low-power and smaller area adder and also compare its performance parameter with different types of adder architecture.

1. Improved 14T full adder

Figure 1 shows the schematic configuration of the full adder cell consisting of 14 Transistors. Feedback transistors provide rail-to-rail outputs in XOR-XNOR module. This type of adder ensures both low power and high speed performance. The power consumed by this circuit is less when compared with that of 10T GDI full adder .

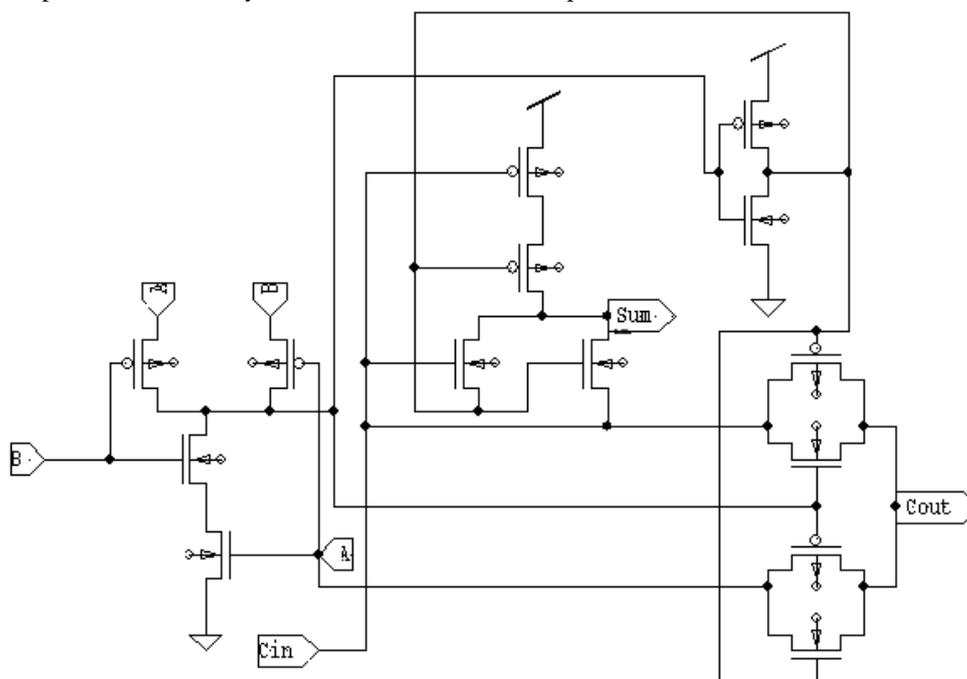


Fig 1: Circuit Diagram of Improved 14 T full adder

II. GDI ADDER

A new low power design technique that solves most of the problems is known as Gate-Diffusion-Input (GDI) method. This technique reduces power consumption, propagation delay, and area of digital circuits. GDI method is based on the use of a simple cell as shown in below figure. At the first look the design seems to be like an inverter, but the main differences are

1. GDI consist of three inputs- G (gate input to NMOS/PMOS), P (input to source of PMOS) and N (input to source of NMOS).
2. Bulks of both NMOS and PMOS are connected to N or P (respectively), so it can be arbitrarily biased at contrast with CMOS inverter.

By using this method a wide variety of logic functions can be implemented using only two transistors. Schematic diagram of GDI based adder is shown in fig 4.13.

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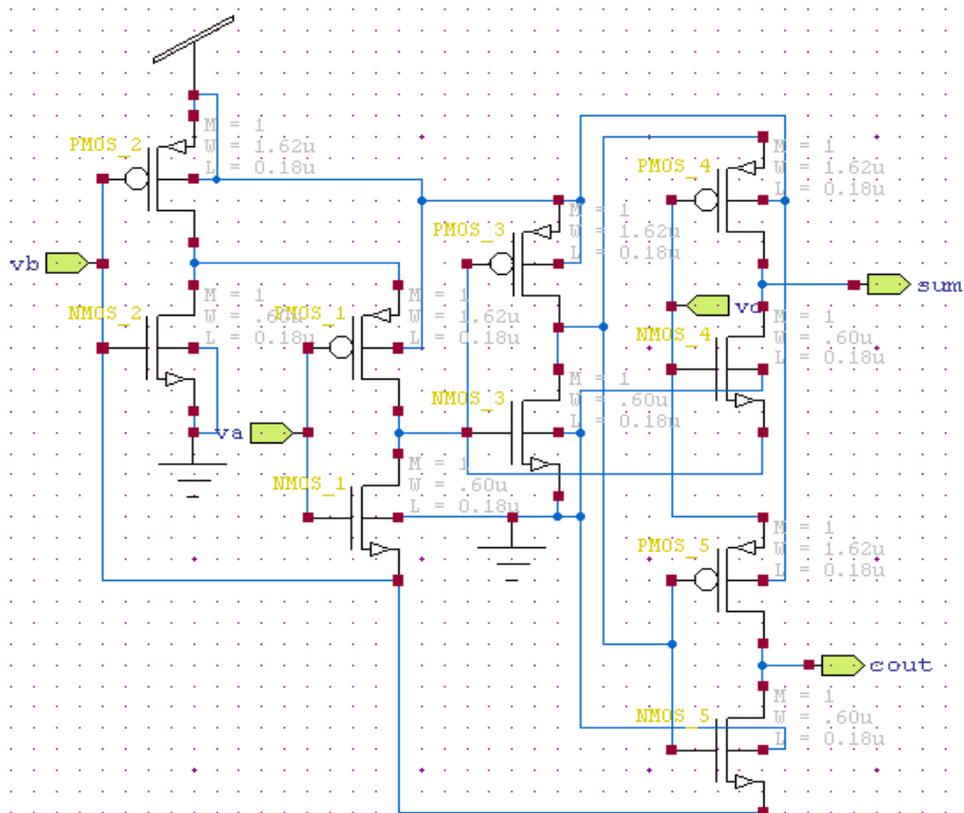


Fig 2: Schematic Diagram of GDI Adder

This method is also suitable for designing fast, low-power circuits, using a less number of transistors, while improving logic level swing and static power characteristics and allowing simple top down design by using small cell library

III. RBSD ADDER

RBSD numbers can be represented using the digit set $(1, 0, \bar{1})$ unlike binary number system, which is represented using binary digit set $(0, 1)$. The decimal value of RBSD number can be calculated by following relation

$$D = \sum_{i=0}^{n-1} x_i 2^i$$

Let the number $(4)_{10}$ can be represented in binary as 0100. The same number in RBSD may be represented by more than one representation i.e. $1\bar{1}00$ or $1\bar{1}\bar{1}00$. Hence in this number system, a number can be represented by more than one way, so called redundant system. Three steps are used in RBSD system in which first and second step generates intermediate data (carry and sum) and third step gives the final result. Therefore the input numbers can be added simultaneously in parallel, as there is no rippling of carry from LSB to MSB. So its speed is fast as compared to other adders. Schematic diagram & layout diagram of RBSD adder is shown below in fig 2 respectively. Total area required for 1-bit RBSD adder is $450 \mu\text{m}^2$.



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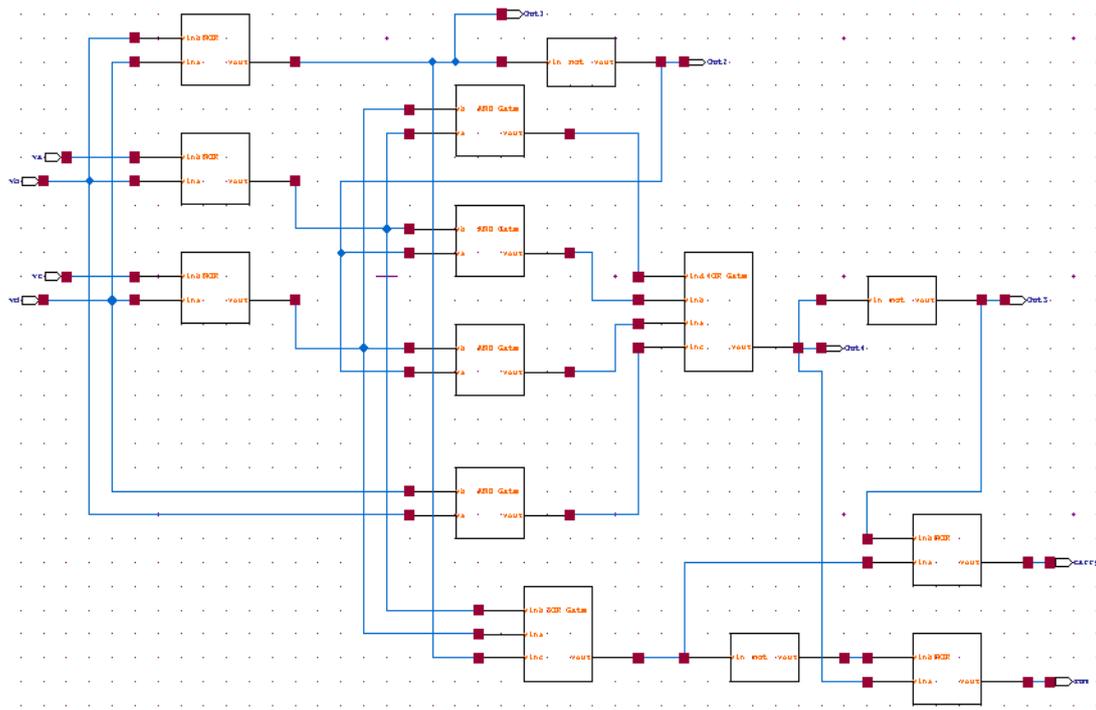


Fig 3: Schematic Diagram of RBSD Adder

RBSD ADDER

Simulated waveform of RBSD adder is shown below in fig 4.

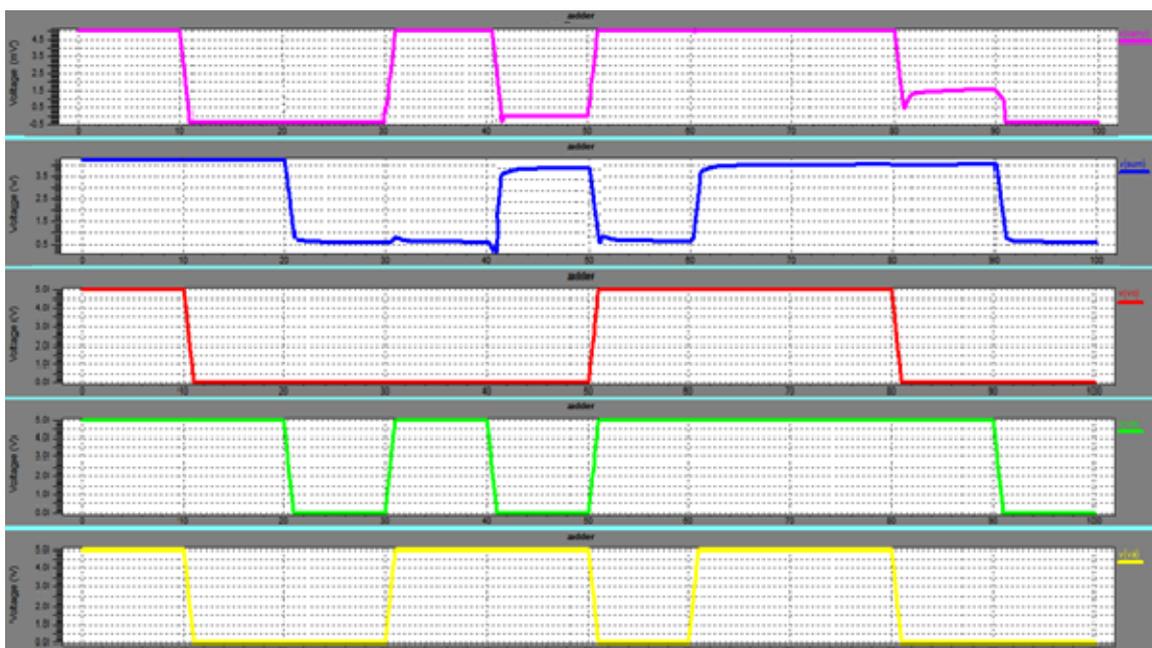


Fig 4: Simulated waveform of RBSD Adder



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Parameters like delay and power dissipation is calculated at different V_{DD} and at different V_{TH} , which is shown in table 1 and table 2 respectively.

Table 1: Parameters of RBSD adder at different V_{DD}

$V_{DD}(V)$	Power Dissipation(mW)	Delay(nS)	
		Sum	Count
1.8	0.989	0.221	0.990
1.6	0.721	0.328	1.303
1.4	0.494	0.350	1.510
1.2	0.288	0.393	1.995
1.0	0.130	0.734	2.621

Table 2: Parameters of RBSD adder at different V_{TH}

$V_{TH}(V)$	Power Dissipation(mW)	Delay(nS)	
		Sum	Count
0.17	0.165	0.218	0.939
0.27	0.240	0.246	0.950
0.37	0.389	0.321	0.998
0.47	0.485	0.374	1.247
0.57	0.789	0.420	1.467

Simulated waveform of RBSD adder which is used for calculation of average power dissipation is shown in fig 5. Formula that is used for average power dissipation is given below

$$\text{Average Power Dissipation} = \frac{P_{\max} + P_{\min}}{2}$$

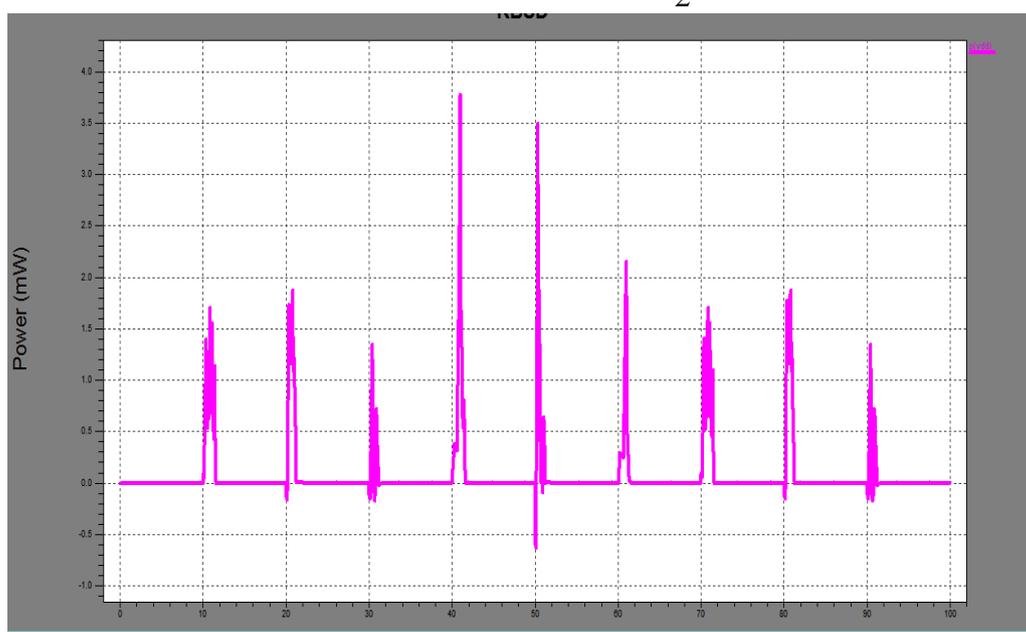


Fig 5: Simulated power waveform of RBSD Adder future scope.



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IV. CONCLUSION

In this paper adder has been designed and simulated using 180 nm CMOS technology of tanner tool at a various supply voltage from 1.0V to 1.8 V & compare their results with respect to various parameter. The comparison has been carried out both assuming circuits with minimum transistors size, to minimize the power consumption. Power consumption is a function of load capacitance, frequency of operation, and supply voltage. A reduction of any one of these is beneficial. A reduction in power consumption provides several benefits. Less heat is generated, which reduces problems associated with high temperature, such as the need for heat sinks. This provides the consumer with a product that costs less. In this paper we conclude that

- The power consumption of GDI based adder is 50% less from RBSD adder but 26% less speed as compared to conventional RBSD adder.
 - Speed & power dissipation of CMOS adder is 10% & 39% less as compared to RBSD.
 - Also CMOS adder has high noise margin as compared to other types of adders.
- Layouts of these adders are also designed using Micro wind. From area comparison we see that area of GDI based adder is 11% less than RBSD adder.

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